



**IRF 540/FI-541/FI
IRF 542/FI-543/FI**

S G S - THOMSON

N - CHANNEL ENHANCEMENT MODE POWER MOS TRANSISTORS

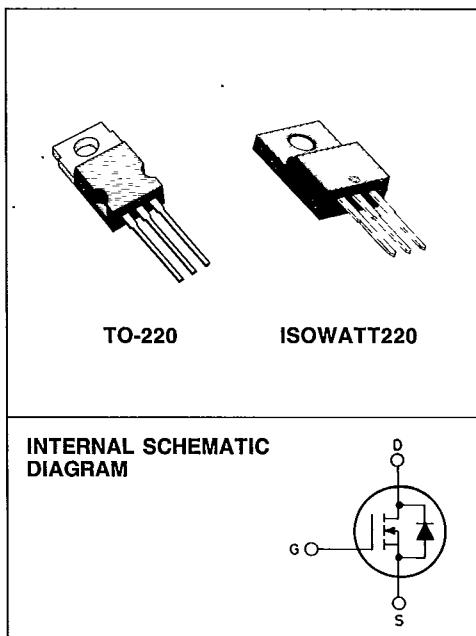
TYPE	V _{DSS}	R _{DS(on)}	I _D
IRF540	100 V	0.077 Ω	28 A
IRF540FI	100 V	0.077 Ω	15 A
IRF541	80 V	0.077 Ω	28 A
IRF541FI	80 V	0.077 Ω	15 A
IRF542	100 V	0.100 Ω	25 A
IRF542FI	100 V	0.100 Ω	14 A
IRF543	80 V	0.100 Ω	25 A
IRF543FI	80 V	0.100 Ω	14 A

- 80-100 VOLTS - FOR DC/DC CONVERTERS
- HIGH CURRENT
- ULTRA FAST SWITCHING
- EASY DRIVE- FOR REDUCED COST AND SIZE

INDUSTRIAL APPLICATIONS:

- UNINTERRUPTIBLE POWER SUPPLIES
- MOTOR CONTROLS

N - channel enhancement mode POWER MOS field effect transistors. Easy drive and very fast switching times make these POWER MOS transistors ideal for high speed switching applications. Applications include DC/DC converters, UPS, battery chargers, secondary regulators, servo control, power-audio amplifiers and robotics.



ABSOLUTE MAXIMUM RATINGS

	TO-220	IRF			
	ISOWATT220	540	541	542	543
		540FI	541FI	542FI	543FI
V _{DS} *	Drain-source voltage (V _{GS} =0)	100	80	100	80
V _{DGR} *	Drain-gate voltage (R _{GS} =20 kΩ)	100	80	100	80
V _{GS}	Gate-source voltage			±20	
I _{DM} (•)	Drain current (pulsed)	110	110	100	100
I _{DLM}	Drain inductive current, clamped (L= 100 μH)	110	110	100	100
		540	541	542	543
I _D	Drain current (cont.) at T _c = 25°C	28	28	25	25
I _D	Drain current (cont.) at T _c = 100°C	20	20	17	17
I _D ■	Drain current (cont.) at T _c = 25°C	540FI	541FI	542FI	543FI
I _D ■	Drain current (cont.) at T _c = 100°C	15	15	14	14
P _{tot} ■	Total dissipation at T _c < 25°C	9	9	8	8
	Derating factor				
T _{stg}	Storage temperature	TO-220	ISOWATT220		
T _j	Max. operating junction temperature	125	40	0.32	W
		1			W/°C
*	T _j = 25°C to 125°C			-55 to 150	°C
(•)	Repetitive Rating: Pulse width limited by max junction temperature.			150	°C
■	See note on ISOWATT220 on this datasheet.				

* T_j = 25°C to 125°C

(•) Repetitive Rating: Pulse width limited by max junction temperature.

■ See note on ISOWATT220 on this datasheet.

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T-39-13

THERMAL DATA

TO-220 | ISOWATT220

R_{thj} - case	Thermal resistance junction-case	max	1	3.12	$^{\circ}\text{C}/\text{W}$
R_{tho-s}	Thermal resistance case-sink	typ	0.5	$^{\circ}\text{C}/\text{W}$	$^{\circ}\text{C}/\text{W}$
$R_{thj-amb}$	Thermal resistance junction-ambient	max	80	$^{\circ}\text{C}/\text{W}$	$^{\circ}\text{C}/\text{W}$
T_J	Maximum lead temperature for soldering purpose		300		$^{\circ}\text{C}$

ELECTRICAL CHARACTERISTICS ($T_{case} = 25^{\circ}\text{C}$ unless otherwise specified)

Parameters	Test Conditions	Min.	Typ.	Max.	Unit
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OFF

$V_{(BR)DSS}$	Drain-source breakdown voltage	$I_D = 250 \mu\text{A}$ for IRF540/542/540FI/542FI for IRF541/543/541FI/543FI	$V_{GS} = 0$	100			V
I_{DSS}	Zero gate voltage drain current ($V_{GS} = 0$)	$V_{DS} = \text{Max Rating}$ $V_{DS} = \text{Max Rating} \times 0.8$	$T_c = 125^{\circ}\text{C}$	80		250	μA
I_{GSS}	Gate-body leakage current ($V_{DS} = 0$)	$V_{GS} = \pm 20 \text{ V}$				± 500	nA

ON **

$V_{GS(\text{th})}$	Gate threshold voltage	$V_{DS} = V_{GS}$	$I_D = 250 \mu\text{A}$	2		4	V
$I_{D(on)}$	On-state drain current	$V_{DS} > I_{D(on)} \times R_{DS(on) \text{ max}}$ for IRF540/541/540FI/541FI for IRF542/543/542FI/543FI	$V_{GS} = 10 \text{ V}$	28			A
$R_{DS(on)}$	Static drain-source on resistance	$V_{GS} = 10 \text{ V}$ for IRF540/541/540FI/541FI for IRF542/543/542FI/543FI	$I_D = 17 \text{ A}$	25		0.077	Ω
						0.100	Ω

DYNAMIC

g_{fs}^{**}	Forward transconductance	$V_{DS} > I_{D(on)} \times R_{DS(on) \text{ max}}$ $I_D = 17 \text{ A}$	8.7			mho
C_{iss} C_{oss} C_{rss}	Input capacitance Output capacitance Reverse transfer capacitance	$V_{DS} = 25 \text{ V}$ $V_{GS} = 0$	f = 1 MHz		1600 800 300	pF pF pF

SWITCHING

$t_d(\text{on})$	Turn-on time	$V_{DD} = 30 \text{ V}$	$I_D = 15 \text{ A}$		30	ns
t_r	Rise time	$R_L = 4.7 \Omega$			60	ns
$t_d(\text{off})$	Turn-off delay time		(see test circuit)		80	ns
t_f	Fall time				30	ns
Q_g	Total Gate Charge	$V_{GS} = 10 \text{ V}$	$I_D = 28 \text{ A}$		59	nC
		$V_{DS} = \text{Max Rating} \times 0.8$	(see test circuit)			

30E D ■ 7929237 0029779 T ■

ELECTRICAL CHARACTERISTICS (Continued)

T-39-13

Parameters	Test Conditions	Min.	Typ.	Max.	Unit
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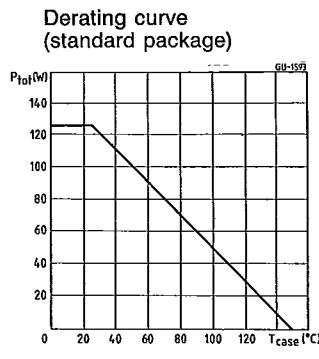
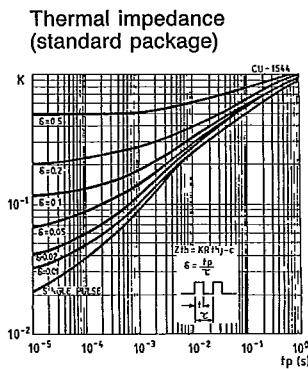
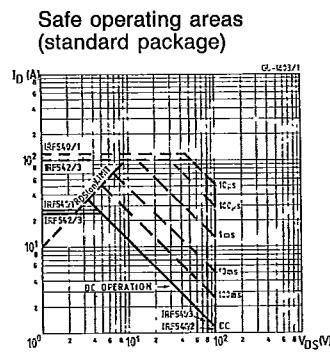
SOURCE DRAIN DIODE

I_{SD} I_{SDM} (*)	Source-drain current Source-drain current (pulsed)			28 110	A A
V_{SD}^{**}	Forward on voltage	$I_{SD} = 28 \text{ A}$	$V_{GS} = 0$		2.5 V
t_{rr}	Reverse recovery time	$T_J = 150^\circ\text{C}$		500	ns
Q_{rr}	Reverse recovered charge	$I_{SD} = 28 \text{ A}$	$dI/dt = 100 \text{ A}/\mu\text{s}$	2.9	μC

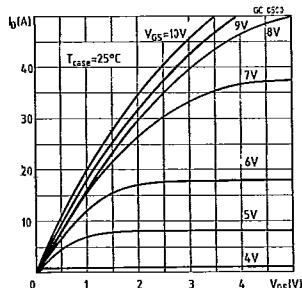
** Pulsed: Pulse duration $\leq 300 \mu\text{s}$, duty cycle $\leq 1.5\%$

(*) Repetitive Rating: Pulse width limited by max junction temperature

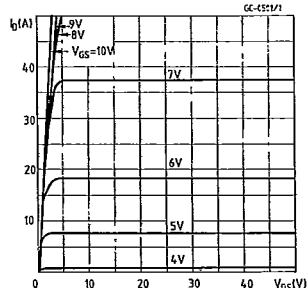
■ See note on ISOWATT220 in this datasheet



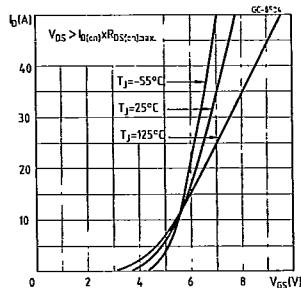
Output characteristics



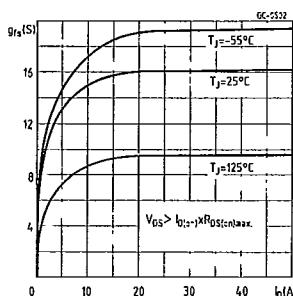
Output characteristics



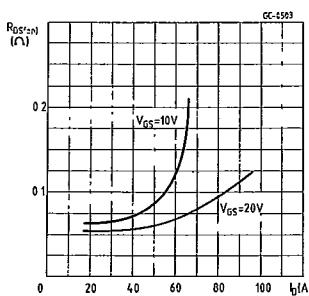
Transfer characteristics



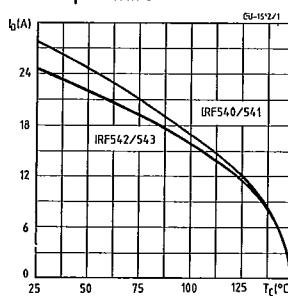
Transconductance



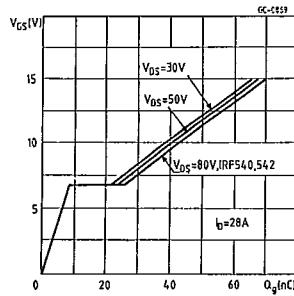
Static drain-source on resistance



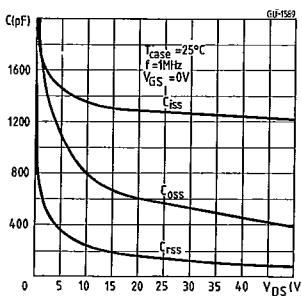
Maximum drain current vs temperature



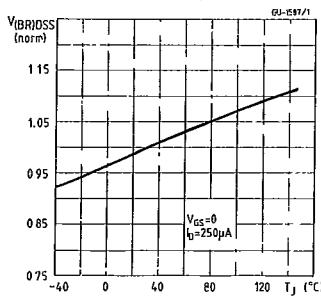
Gate charge vs gate-source voltage



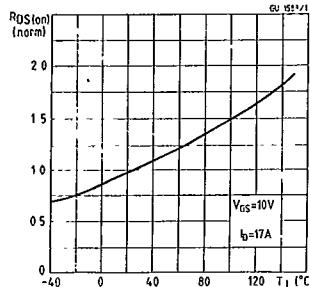
Capacitance variation



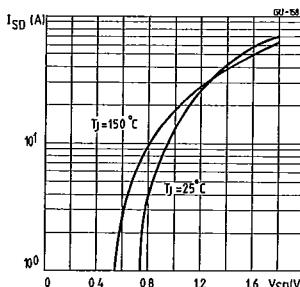
Normalized breakdown voltage vs temperature



Normalized on resistance vs temperature



Source-drain diode forward characteristics



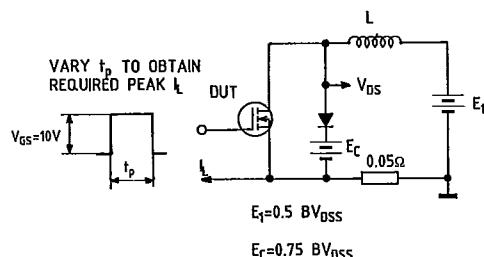
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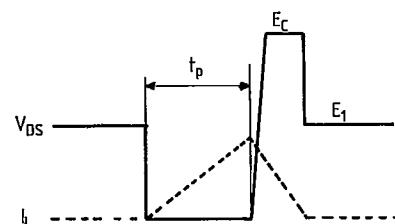
T-39-13

Clamped inductive test circuit

Clamped inductive waveforms

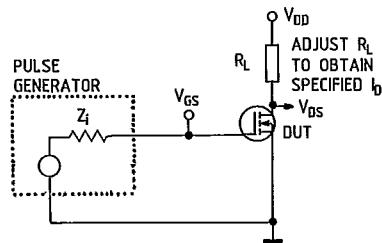


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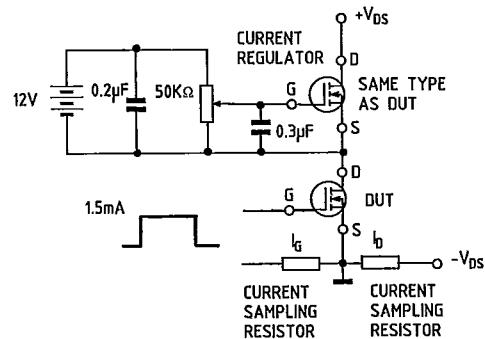
SC-0243

Switching times test circuit



SC-0246

Gate charge test circuit



SC-0244

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T-39-13

ISOWATT220 PACKAGE**CHARACTERISTICS AND APPLICATION.**

ISOWATT220 is fully isolated to 2000V dc. Its thermal impedance, given in the data sheet, is optimised to give efficient thermal conduction together with excellent electrical isolation.

The structure of the case ensures optimum distances between the pins and heatsink. The ISOWATT220 package eliminates the need for external isolation so reducing fixing hardware. Accurate moulding techniques used in manufacture assure consistent heat spreader-to-heatsink capacitance.

ISOWATT220 thermal performance is better than that of the standard part, mounted with a 0.1mm mica washer. The thermally conductive plastic has a higher breakdown rating and is less fragile than mica or plastic sheets. Power derating for ISOWATT220 packages is determined by:

$$P_D = \frac{T_J - T_c}{R_{th}}$$

from this I_{Dmax} for the POWER MOS can be calculated:

$$I_{Dmax} \leq \sqrt{\frac{P_D}{R_{DS(on)} \text{ (at } 150^\circ\text{C)}}}$$

THERMAL IMPEDANCE OF ISOWATT220 PACKAGE

Fig. 1 illustrates the elements contributing to the thermal resistance of transistor heatsink assembly, using ISOWATT220 package.

The total thermal resistance $R_{th(\text{tot})}$ is the sum of each of these elements.

The transient thermal impedance, Z_{th} for different pulse durations can be estimated as follows:

1 - for a short duration power pulse less than 1ms;

$$Z_{th} < R_{thJ-C}$$

2 - for an intermediate power pulse of 5ms to 50ms:

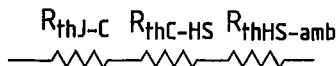
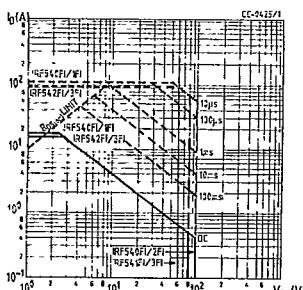
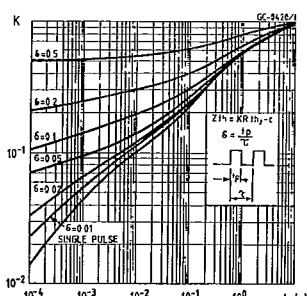
$$Z_{th} = R_{thJ-C}$$

3 - for long power pulses of the order of 500ms or greater:

$$Z_{th} = R_{thJ-C} + R_{thC-HS} + R_{thHS-amb}$$

It is often possible to discern these areas on transient thermal impedance curves.

Fig. 1

**ISOWATT DATA****Safe operating areas****Thermal impedance****Derating curve**